

<b>Notice of References Cited</b>	Application/Control No. 10/068,004	Applicant(s)/Patent Under Reexamination SO ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,837,568	11-1998	Yoneda et al.	438/147
	B	US-5,550,066	08-1996	Tang et al.	438/29
	C	US-			
	D	US-			
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	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 11-261076	09-1999	Japan	Yamazaki et al	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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